EcoSPARK® 2 N-Channel Ignition IGBT

335 mJ, 400 V

FGD3440G2-F085V

Features

- SCIS Energy = 335 mJ at $T_J = 25^{\circ}C$
- Logic Level Gate Drive
- AEC-Q101 Qualified and PPAP Capable
- These Devices are Pb-Free and are RoHS Compliant

Applications

- Automotive Ignition Coil Driver Circuits
- High Current Ignition System
- Coil on Plug Application

MAXIMUM RATINGS ($T_J = 25^{\circ}C$ unless otherwise noted)

| Symbol | Parameter | Value | Unit |
|----------------------|---|-------------|------|
| BV _{CER} | Collector to Emitter Breakdown Voltage (I _C = 1 mA) | 400 | V |
| BV _{ECS} | Emitter to Collector Voltage – Reverse Battery Condition (I _C = 10 mA) | 28 | ٧ |
| E _{SCIS25} | Self Clamping Inductive Switching Energy (Note 1) | 335 | mJ |
| E _{SCIS150} | Self Clamping Inductive Switching Energy (Note 2) | 195 | mJ |
| I _{C25} | Collector Current Continuous at $V_{GE} = 4.0 \text{ V}$, $T_C = 25^{\circ}\text{C}$ | 26.9 | Α |
| I _{C110} | Collector Current Continuous at V _{GE} = 4.0 V, T _C = 110°C | 25 | Α |
| V_{GEM} | Gate to Emitter Voltage Continuous | ±10 | V |
| P_{D} | Power Dissipation Total, T _C = 25°C | 166 | W |
| | Power Dissipation Derating, $T_C > 25^{\circ}C$ | 1.1 | W/°C |
| T_J | Operating Junction and Storage Temperature | -40 to +175 | °C |
| T _{STG} | Storage Junction Temperature Range | -40 to +175 | °C |
| TL | Max. Lead Temperature for Soldering (Leads at 1.6 mm from case for 10 s) | 300 | °C |
| T _{PKG} | Max. Lead Temperature for Soldering (Package Body for 10 s) | 260 | °C |
| ESD | HBM-Electrostatic Discharge Voltage at 100 pF, 1500 Ω | 4 | kV |

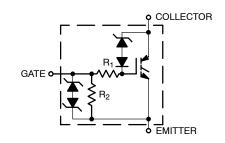
Stresses exceeding those listed in the Maximum Ratings table may damage the device. If any of these limits are exceeded, device functionality should not be assumed, damage may occur and reliability may be affected.

- Self clamped inductive Switching Energy (ESCIS25) of 335 mJ is based on the test conditions that is starting T_J = 25°C, L = 3 mHy, ISCIS = 15 A, VCC = 100 V during inductor charging and VCC = 0 V during time in clamp.
- Self Clamped inductive Switching Energy (ESCIS150) of 195 mJ is based on the test conditions that is starting T_J = 150°C, L = 3mHy, ISCIS = 11.4 A, VCC = 100 V during inductor charging and VCC = 0 V during time in clamp.



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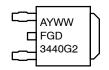
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DPAK (SINGLE GAUGE) CASE 369C

MARKING DIAGRAM



A = Assembly Location Y = Year

WW = Work Week FGD3440G2= Device Code

ORDERING INFORMATION

See detailed ordering and shipping information on page 2 of this data sheet.

FGD3440G2-F085V

THERMAL RESISTANCE RATINGS

| Characteristic | Symbol | Max | Units |
|---|----------------|-----|-------|
| Junction-to-Case - Steady State (Drain) | $R_{	heta JC}$ | 0.9 | °C/W |

ELECTRICAL CHARACTERISTICS (T_J = 25°C unless otherwise specified)

| Symbol | Parameter | Test Conditions | | Min | Тур | Max | Units |
|----------------------|---|---|---|------|-----|------|-------|
| OFF CHARA | ACTERISTICS | | | | | | |
| BV _{CER} | Collector to Emitter Breakdown Voltage | $I_{CE} = 2 \text{ mA}, V_{GE} = 0 \text{ V}, \\ R_{GE} = 1 \text{ k}\Omega, T_{J} = -40 \text{ to } 150^{\circ}\text{C}$ | | 370 | 400 | 430 | V |
| BV _{CES} | Collector to Emitter Breakdown Voltage | I _{CE} = 10 mA, V _{GE} = 0 V, R _{GE} = 0, T _J = -40 to 150°C | | 390 | 420 | 450 | V |
| BV _{ECS} | Emitter to Collector Breakdown Voltage | I _{CE} = -20 mA, V _{GE} = 0 V, T _J = 25°C | | 28 | - | - | V |
| BV _{GES} | Gate to Emitter Breakdown Voltage | I _{GES} = ±2 mA | | ±12 | ±14 | - | V |
| I _{CER} | Collector to Emitter Leakage Current | V _{CE} = 250 V | T _J = 25°C | - | - | 25 | μΑ |
| | | $R_{GE} = 1 k\Omega$ | T _J = 150°C | - | - | 1 | mA |
| I _{ECS} | Emitter to Collector Leakage Current | Current V _{EC} = 24 V | T _J = 25°C | - | - | 1 | mA |
| | | | T _J = 150°C | - | - | 40 | 1 |
| R ₁ | Series Gate Resistance | | • | - | 120 | - | Ω |
| R ₂ | Gate to Emitter Resistance | | | 10K | - | 30K | Ω |
| ON CHARAC | CTERISTICS (Note 5) | | | | | | |
| V _{CE(SAT)} | Collector to Emitter Saturation Voltage | I _{CE} = 6 A, V _{GE} = 4 V, T _J = 25°C | | - | 1.1 | 1.2 | V |
| | | I _{CE} = 10 A, V _{GE} = 4.5 V, T _J = 150°C | | - | 1.3 | 1.45 | 1 |
| | | | I _{CE} = 15 A, V _{GE} = 4.5 V, T _J = 150°C | | 1.6 | 1.75 | 1 |
| OYNAMIC C | HARACTERISTICS | | | | | | |
| Q _{G(ON)} | Gate Charge | I _{CE} = 10 A, V _{CE} = 12 V, V _{GE} = 5 V | | - | 24 | - | nC |
| V _{GE(TH)} | Gate to Emitter Threshold Voltage | I _{CE} = 1 mA V _{CE} = V _{GE} | T _J = 25°C | 1.3 | 1.7 | 2.2 | ٧ |
| | | | T _J = 150°C | 0.75 | 1.2 | 1.8 | |
| V _{GEP} | Gate to Emitter Plateau Voltage | V _{CE} = 12 V, I _{CE} = 10 A | | - | 2.8 | - | V |
| SWITCHING | CHARACTERISTICS | - | | - | - | - | - |
| t _{d(ON)R} | Current Turn-On Delay Time-Resistive | $V_{CE} = 14 \text{ V}, R_{L} = 1 \Omega, V_{GE} = 5 \text{ V},$ $R_{G} = 1 \text{ K}\Omega, T_{J} = 25^{\circ}\text{C}$ | | _ | 1.0 | 4 | μs |
| t _{rR} | Current Rise Time-Resistive | | | - | 2.0 | 7 | 1 |
| t _{d(OFF)L} | Current Turn-Off Delay Time-Inductive | | 1 mH, V _{GE} = 5 V, | - | 5.3 | 10 | 1 |
| t _{fL} | Current Fall Time-Inductive | $R_G = 1K\Omega$, $I_{CE} = 6.5 A$, $T_J = 25^{\circ}C$ | | - | 2.3 | 15 | 1 |
| | | • | | • | | | |

Product parametric performance is indicated in the Electrical Characteristics for the listed test conditions, unless otherwise noted. Product performance may not be indicated by the Electrical Characteristics if operated under different conditions.

PACKAGE MARKING AND ORDERING INFORMATION

| Device Marking | Device | Package | Reel Diameter | Tape Width | Qty [†] |
|----------------|-----------------|----------------|---------------|------------|------------------|
| FGD3440G2 | FGD3440G2-F085V | DPAK (Pb-Free) | 330 mm | 16 mm | 2500 |

[†]For information on tape and reel specifications, including part orientation and tape sizes, please refer to our Tape and Reel Packaging Specifications Brochure, BRD8011/D.

TYPICAL CHARACTERISTICS

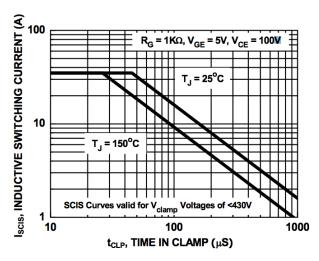


Figure 1. Self Clamped Inductive Switching Current vs. Time in Clamp

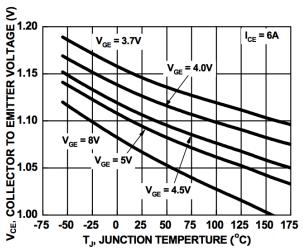


Figure 3. Collector to Emitter On–State Voltage vs. Junction Temperature

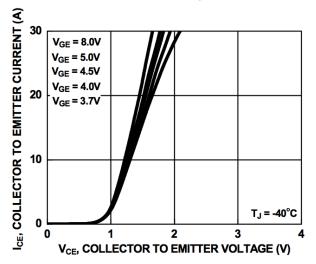


Figure 5. Collector to Emitter On–State Voltage vs. Collector Current

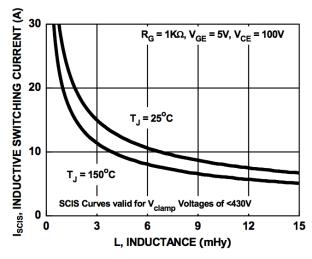


Figure 2. Self Clamped Inductive Switching Current vs. Inductance

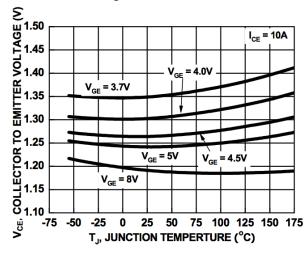


Figure 4. Collector to Emitter On-State Voltage vs. Junction Temperature

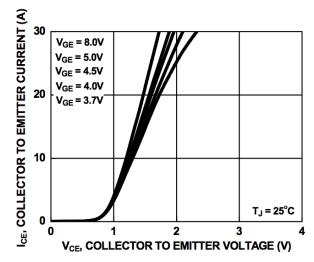


Figure 6. Collector to Emitter On-State Voltage vs. Collector Current

TYPICAL CHARACTERISTICS (continued)

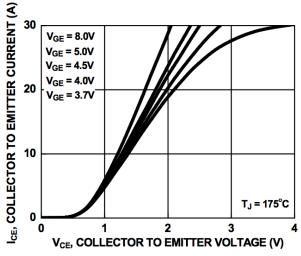


Figure 7. Collector to Emitter On-State Voltage vs. Collector Current

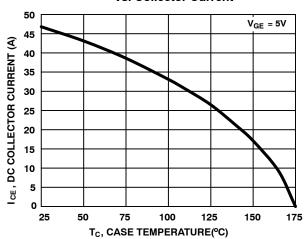


Figure 9. DC Collector Current vs. Case Temperature

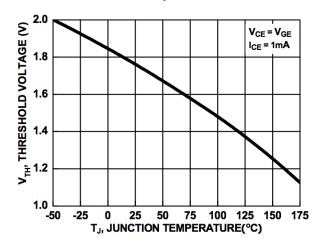


Figure 11. Threshold Voltage vs. Junction Temperature

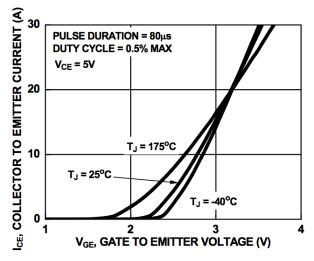


Figure 8. Transfer Characteristics

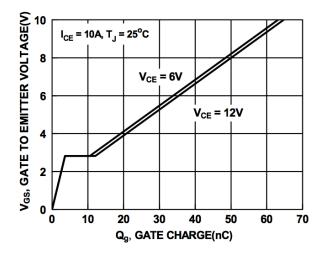


Figure 10. Gate Charge

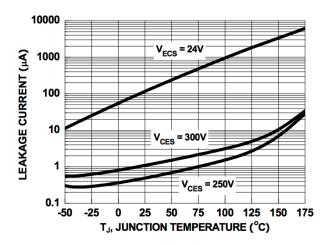
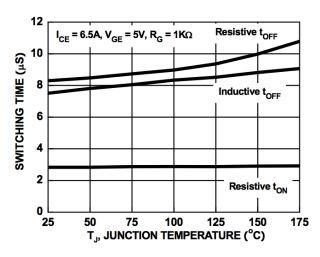


Figure 12. Leakage Current vs. Junction Temperature

FGD3440G2-F085V

TYPICAL CHARACTERISTICS (continued)



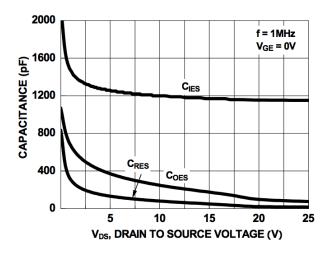


Figure 13. Switching Time vs. Junction Temperature

Figure 14. Capacitance vs. Collector to Emitter

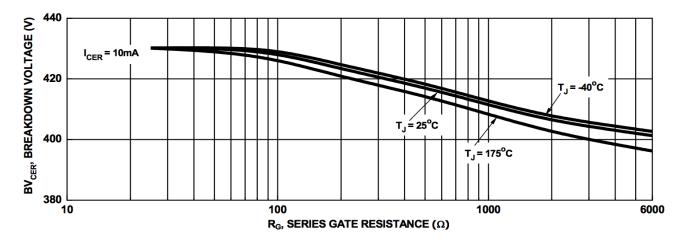


Figure 15. Break Down Voltage vs. Series Resistance

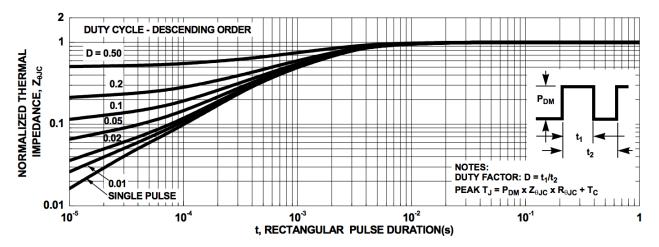
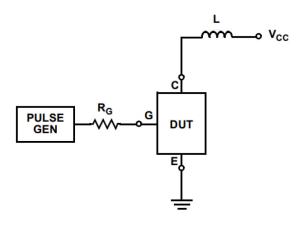


Figure 16. IGBT Normalized Transient Thermal Impedance, Junction to Case

FGD3440G2-F085V

TEST CIRCUIT AND WAVEFORMS



 $R_{G} = 1K\Omega$ G DUT E V_{CC}

Figure 17. Inductive Switching Test Circuit

Figure 18. t_{ON} and t_{OFF} Switching Test Circuit

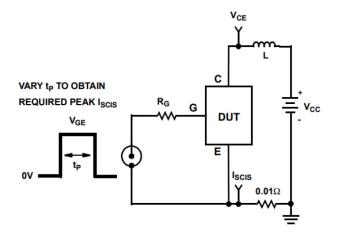


Figure 19. Energy Test Circuit

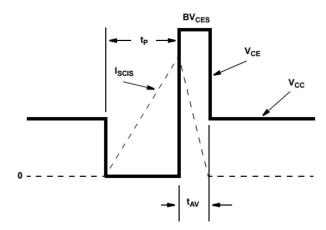
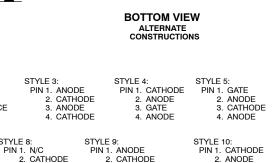


Figure 20. Energy Waveforms



DPAK (SINGLE GAUGE) CASE 369C **ISSUE F** SCALE 1:1 Α <-b3 В L3 Z ۩ **DETAIL A** Ш NOTE 7 C → **BOTTOM VIEW** h2 e SIDE VIEW ⊕ 0.005 (0.13) M C **TOP VIEW** Z H L2 GAUGE C SEATING PLANE



3. CATHODE 4. ANODE

3. RESISTOR ADJUST 4. CATHODE

SOLDERING FOOTPRINT*

3. ANODE 4. CATHODE

STYLE 8:

Α1

PIN 1. GATE 2. DRAIN

SOURCE

4. DRAIN

STYLE 2:

PIN 1. GATE 2. COLLECTOR

3. EMITTER 4. COLLECTOR

DETAIL A ROTATED 90° CW

STYLE 7:

STYLE 1:

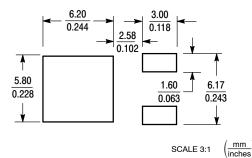
STYLE 6:

PIN 1. MT1 2. MT2

3. GATE 4. MT2

PIN 1. BASE 2. COLLECTOR 3. EMITTER

4. COLLECTOR



*For additional information on our Pb-Free strategy and soldering details, please download the ON Semiconductor Soldering and Mounting Techniques Reference Manual, SOLDERRM/D.

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DATE 21 JUL 2015

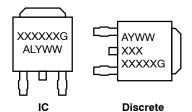
NOTES:

- 1. DIMENSIONING AND TOLERANCING PER ASME Y14.5M, 1994. 2. CONTROLLING DIMENSION: INCHES.
- 3. THERMAL PAD CONTOUR OPTIONAL WITHIN DI-
- MENSIONS b3, L3 and Z.
 4. DIMENSIONS D AND E DO NOT INCLUDE MOLD FLASH, PROTRUSIONS, OR BURRS. MOLD FLASH, PROTRUSIONS, OR GATE BURRS SHALL NOT EXCEED 0.006 INCHES PER SIDE.
 5. DIMENSIONS D AND E ARE DETERMINED AT THE
- OUTERMOST EXTREMES OF THE PLASTIC BODY.

 6. DATUMS A AND B ARE DETERMINED AT DATUM
- 7. OPTIONAL MOLD FEATURE.

| | INCHES | | MILLIMETERS | |
|-----|-----------|-------|-------------|-------|
| DIM | MIN | MAX | MIN | MAX |
| Α | 0.086 | 0.094 | 2.18 | 2.38 |
| A1 | 0.000 | 0.005 | 0.00 | 0.13 |
| b | 0.025 | 0.035 | 0.63 | 0.89 |
| b2 | 0.028 | 0.045 | 0.72 | 1.14 |
| b3 | 0.180 | 0.215 | 4.57 | 5.46 |
| С | 0.018 | 0.024 | 0.46 | 0.61 |
| c2 | 0.018 | 0.024 | 0.46 | 0.61 |
| D | 0.235 | 0.245 | 5.97 | 6.22 |
| E | 0.250 | 0.265 | 6.35 | 6.73 |
| е | 0.090 | BSC | 2.29 BSC | |
| Н | 0.370 | 0.410 | 9.40 | 10.41 |
| L | 0.055 | 0.070 | 1.40 | 1.78 |
| L1 | 0.114 REF | | 2.90 REF | |
| L2 | 0.020 BSC | | 0.51 BSC | |
| L3 | 0.035 | 0.050 | 0.89 | 1.27 |
| L4 | | 0.040 | | 1.01 |
| Z | 0.155 | | 3.93 | |

GENERIC MARKING DIAGRAM*



XXXXXX = Device Code = Assembly Location Α L = Wafer Lot Υ = Year

WW = Work Week = Pb-Free Package

*This information is generic. Please refer to device data sheet for actual part marking. Pb-Free indicator, "G" or microdot "■", may or may not be present. Some products may not follow the Generic Marking.

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| DESCRIPTION: | DPAK (SINGLE GAUGE) | | PAGE 1 OF 1 | |

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